Ec241a, Spring 2023

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Problem Set 2

Due: April 5, 2023

Problem sets are due in class. You may work in groups (indeed I encourage you to all work together), but each student should turn in their own write-up.

Production function estimation using panel data

Readings: Olley and Pakes (1996), Blundell and Bond (2000), Bloom et al. (2013), de Loecker (2013)

The file semiconductor_firms.out, available in the Problem Sets folder on the course GitHub, contains information on 113 semiconductor firms (NAICS 4-digit code 3344) for the years 2010 to 2014 (i.e., t = 0, 1, ..., T with T = 4 – four periods plus an initial condition). Each row of the dataset corresponds to a firm-year observation. Included in the file are the variables:

Y, output (specifically total sales, in millions of dollars, deflated by an industry-specific output price index)

K, total capital (gross property, plant and equipment in millions of dollars deflated by an industry-by-estimated-capital-age-specific capital price index)

L, total employed labor (thousands of workers)

M, materials (specifically total sales minus operating income before depreciation minus total labor expenses minus R&D expenditures, deflated by an industry-specific output price index)

VA, valued added (Y - M) – note that a few firm-year VA measures are negative. This typically reflects a firm reporting negative operating income before depreciation in a given year). You will need to drop firms with any negative firm-year VA measures from your estimation sample.

r&d, total spending on research and development (deflated by an industry-specific investment price index) w, industry-specific average annual pay measure (deflated by an industry-specific output price index)

i, total capital expenditure (i.e., investment) in millions of dollars (deflated by an industry-specific investment price index)

You will use this dataset to estimate the parameters of a value added production function of the form

$$VA_{it} = K_{it}^{\alpha} L_{it}^{\beta} \exp\left(A_{it} + U_{it}\right)$$

with U_{it} an unforecastable productivity shock which is realized after all period t input decisions are made and A_{it} a systematic productivity component with

$$A_{it} = h\left(A_{it-1}, X_{it-1}\right) + \epsilon_{it}, \ \mathbb{E}\left[\epsilon_{it} | \mathcal{I}_{it}\right] = 0$$

with \mathcal{I}_{it} firm i's beginning-of-period t information set and X_{it} expenditure on research and development. Both capital and labor are costly adjust, such that

$$L_{it} = g_L\left(L_{it-1}, K_{it}, A_{it}; W_t\right)$$

$$I_{it} = g_K\left(L_{it}, K_{it}, A_{it}; W_t\right)$$

with I_{it} equal to period t capital expenditures (which are reflected in the period t+1 capital stock) and W_t a vector industry-specific input prices.

- 1. Let $Z_0^t = (Z_0, \ldots, Z_t)'$. What elements of L_0^T , K_0^T , I_0^T , I_0^T , I_0^T and VA_0^T are part of \mathcal{I}_t ? In what sense is the estimation problem a sequential moments one?
- 2. Comment on the restriction that $A_{it} \perp \mathcal{I}_{it} | A_{it-1}, X_{it-1}$. Give a few examples of how it could be violated.
- 3. Implement the following algorithm (e.g., Bloom et al., 2019, p. 1656):
 - (a) Compute the OLS fit of $\ln Y_{it}$ onto $\ln K_{it}$, $\ln L_{it}$, $\ln X_{it}$, a vector of firm-specific dummy variables and a vector of time-specific dummy variables.
 - (b) Discuss the problems, if any, with this approach in light of the economic model sketched above.
- 4. Compute estimates of α , β and $h(A_{it-1}, X_{it-1})$ using the "Olley-Pakes" procedure described in lecture (carefully describe any modeling/implementation choices you make).
- 5. Assume that $h(A_{it-1}, X_{it-1})$ is linear. Now estimate using the "Blundell-Bond" procedure described in lecture.
- 6. Summarize your empirical findings.
- 7. Provide measures of statistical precision for as many estimated parameters as you are able to. Justify your measures as well as you are able to.
- 8. Discuss how you might construct an estimator with greater precision?

Nonlinear panel data

Readings: Chamberlain (1980), Chamberlain (1985), Hahn (1994), Arellano (2003)

Let t = 1, 2 index two spells, of lengths Y_1 and Y_2 . For example Y_1 might equal time spent of first job, Y_2 time spent on second job. Alternatively Y_1 might be time to first publication post PhD, and Y_2 the time that elapses between the first and second post-PhD publication etc. Let X_t be a vector of spell-varying regressors and A spell-invariant heterogeneity. Assume that the hazard function takes the form

$$\lambda_0(y_t|x, a; \theta_0) = \lambda_0(y_t, \alpha_0) \exp(x_t'\beta_0 + a), t = 1, 2$$

with $\theta=(\alpha,\beta')'$ and $\lambda_0\left(y_t,\alpha\right)$ a known baseline hazard function indexed by α . You may assume that Y_1 and Y_2 are conditionally independent given $X=(X_1,X_2)'$ and A. Let $Z=(X_1',Y_1,X_2'Y_2)'$ and assume that $\{(Z_i',A_i)\}_{i=1}^{\infty}$ is an iid sequence with A_i unobserved. Let $\rho\left(z_t,\theta\right)=\Lambda_0\left(y_1,\alpha\right)\exp\left(x_t'\beta\right)$ for t=1,2 with $z_t=(x_t',y_t)'$ and $\bar{\rho}\left(z,\theta\right)=\rho\left(z_1,\theta\right)+\rho\left(z_2,\theta\right)$. Additionally define the random variables $P_1=\rho\left(Z_1,\theta_0\right)$, $P_2=\rho\left(Z_2,\theta_0\right)$ and $\bar{P}=P_1+P_2$.

[a] Show that the joint density for the two spells given X = x and A = a

$$f_{Y_{1},Y_{2}|X,A}(y_{1},y_{2}|x,a;\theta_{0}) = \lambda_{0}(y_{1},\alpha_{0}) \exp(x'_{1}\beta_{0}) \lambda_{0}(y_{2},\alpha_{0}) \exp(x'_{2}\beta_{0}) \frac{f_{\bar{P}|A}(\bar{\rho}(z,\theta_{0})|a)}{\bar{\rho}(z,\theta_{0})}$$

where $f_{\bar{P}|A}\left(\left.v\right|a\right)=e^{2a}v\exp\left(-e^{a}v\right)$ is the density for the Gamma $(2,e^{a})$ random variable \bar{P} at $\bar{P}=v$.

[b] Let $\pi(a|x)$ be the unknown density for the conditional distribution of A given X such that

$$f_{\bar{P}|X}(\bar{\rho}|x) = \int e^{2a}\bar{\rho}\exp(-e^{a}\bar{\rho})\pi(a|x)da.$$

Show that

$$\frac{\frac{\partial}{\partial \bar{\rho}} f_{\bar{P}|X}\left(\bar{\rho}|x\right)}{f_{\bar{P}|X}\left(\bar{\rho}|x\right)} = \frac{1}{\bar{\rho}} - \mathbb{E}\left[e^{A}|\bar{\rho},x\right].$$

[c] Consider the joint fixed effects estimator which treats $\delta_i = e^{A_i}$ as an additional parameter to be estimated. Show that unit i's contribution to the log-likelihood function in this case is

$$l_{i}^{\text{JFE}}(\theta, \delta_{i}) = \ln \lambda_{0} (Y_{i1}, \alpha) + \ln \lambda_{0} (Y_{i2}, \alpha) + (X_{i1} + X_{i2})' \beta + 2 \ln \delta_{i} - [\rho (Z_{i1}, \theta) + \rho (Z_{i2}, \theta)] \delta_{i}.$$
(1)

[d] Show that for a fixed value of θ , the MLE of δ_i is

$$\hat{\delta}_{i}\left(\theta\right) = \left[\frac{\rho\left(Z_{i1},\theta\right) + \rho\left(Z_{i2},\theta\right)}{2}\right]^{-1}.$$

Observe that $\hat{\delta}_i(\theta)$ only varies with unit *i*'s data.

[e] Show that unit i's contribution to the concentrated log-likelihood function equals

$$l_{i}^{\mathrm{JFE}}\left(\theta,\hat{\delta}_{i}\left(\theta\right)\right) = \ln\lambda_{0}\left(Y_{i1},\alpha\right) + \ln\lambda_{0}\left(Y_{i2},\alpha\right) + \left(X_{i1} + X_{i2}\right)'\beta - 2\ln\left[\frac{\rho\left(Z_{1i},\theta\right) + \rho\left(Z_{i2},\theta\right)}{2}\right] - 2.$$

[f] Show that the point fixed effects estimate of β solves the sample analog of the population moment restriction

$$\mathbb{E}\left[\psi^{\text{JFE}}\left(Z_{i},\theta\right)\right] = \mathbb{E}\left[-\left(X_{i2} - X_{i1}\right) \left\{\frac{\rho\left(Z_{2i},\theta\right) - \rho\left(Z_{1i},\theta\right)}{\rho\left(Z_{i1},\theta\right) + \rho\left(Z_{2i},\theta\right)}\right\}\right] = 0.$$

Show that $\mathbb{E}\left[\psi^{\text{JFE}}\left(Z_{i},\theta\right)\right]$ is, indeed, mean zero at $\theta=\theta_{0}$. Discuss your finding in light of what you know about incidental parameters bias. Can you say anything about the JFE estimate of α_{0} , the parameter indexing the baseline hazard? Discuss.

References

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